

**Notice of References Cited**

Application/Control No.

10/082,517

Applicant(s)/Patent Under  
Reexamination  
SANCHEZ ET AL.

Examiner

Magid Y Dimyan

Art Unit

2825

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,182,247 ✓	01-2001	Herrmann et al.	714/39
	B	US-2003/0097615 ✓	05-2003	Corti et al.	714/37
	C	US-2001/0037477 ✓	11-2001	Veenstra et al.	714/41
	D	US-6,564,347 ✓	05-2003	Mates, John W.	714/727
	E	US-6,442,725 ✓	08-2002	Schipke et al.	714/741
	F	US-2003/0110429 ✓	06-2003	Bailis et al.	714/725
	G	US-2003/0110453 ✓	06-2003	Bailis et al.	716/1
	H	US-2002/0194543 ✓	12-2002	Veenstra et al.	714/39
	I	US-6,389,558 ✓	05-2002	Herrmann et al.	714/39
	J	US-6,502,209 ✓	12-2002	Bengtsson et al.	714/35
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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